

<b>Notice of References Cited</b>		Application/Control No. 10/666,723	Applicant(s)/Patent Under Reexamination ZENG ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0146091 A1	07-2004	Chang et al.	375/147
*	B	US-2004/0235439 A1	11-2004	Husted et al.	455/136
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**FOREIGN PATENT DOCUMENTS**

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